
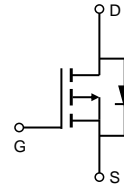
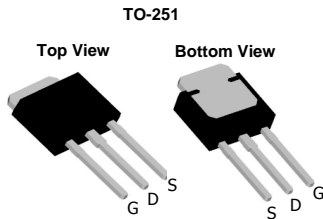


## TMI2658 P-CHANNEL POWER MOSFET

<p><b>General Description</b></p> <ul style="list-style-type: none"> <li>• Trench Power MV MOSFET technology</li> <li>• Low <math>R_{DS(ON)}</math></li> <li>• Low Gate Charge</li> <li>• Optimized for fast-switching applications</li> </ul> <p><b>Applications</b></p> <ul style="list-style-type: none"> <li>• Synchronous Rectification in DC/DC and AC/DC Converters</li> <li>• Industrial and Motor Drive applications</li> </ul>	<p><b>Product Summary</b></p> <table style="width: 100%; border: none;"> <tr> <td style="padding: 2px;"><math>V_{DS}</math></td> <td style="padding: 2px; text-align: right;">-60V</td> </tr> <tr> <td style="padding: 2px;"><math>I_D</math> (at <math>V_{GS}=-10V</math>)</td> <td style="padding: 2px; text-align: right;">-26A</td> </tr> <tr> <td style="padding: 2px;"><math>R_{DS(ON)}</math> (at <math>V_{GS}=-10V</math>)</td> <td style="padding: 2px; text-align: right;">&lt; 40m<math>\Omega</math></td> </tr> <tr> <td style="padding: 2px;"><math>R_{DS(ON)}</math> (at <math>V_{GS}=-4.5V</math>)</td> <td style="padding: 2px; text-align: right;">&lt; 55m<math>\Omega</math></td> </tr> </table> <p>100% UIS Tested 100% Rg Tested</p> <div style="text-align: right;">  </div>	$V_{DS}$	-60V	$I_D$ (at $V_{GS}=-10V$ )	-26A	$R_{DS(ON)}$ (at $V_{GS}=-10V$ )	< 40m $\Omega$	$R_{DS(ON)}$ (at $V_{GS}=-4.5V$ )	< 55m $\Omega$
$V_{DS}$	-60V								
$I_D$ (at $V_{GS}=-10V$ )	-26A								
$R_{DS(ON)}$ (at $V_{GS}=-10V$ )	< 40m $\Omega$								
$R_{DS(ON)}$ (at $V_{GS}=-4.5V$ )	< 55m $\Omega$								



**Absolute Maximum Ratings**  $T_A=25^\circ\text{C}$  unless otherwise noted

Parameter	Symbol	Maximum	Units
Drain-Source Voltage	$V_{DS}$	-60	V
Gate-Source Voltage	$V_{GS}$	$\pm 20$	V
Continuous Drain Current	$I_D$	$T_C=25^\circ\text{C}$	A
		$T_C=100^\circ\text{C}$	
Pulsed Drain Current <sup>C</sup>	$I_{DM}$	-80	
Avalanche Current <sup>C</sup>	$I_{AS}$	-26	A
Avalanche energy $L=0.1\text{mH}$ <sup>C</sup>	$E_{AS}$	34	mJ
Power Dissipation <sup>B</sup>	$P_D$	$T_C=25^\circ\text{C}$	W
		$T_C=100^\circ\text{C}$	
Power Dissipation <sup>A</sup>	$P_{DSM}$	$T_A=25^\circ\text{C}$	W
		$T_A=70^\circ\text{C}$	
Junction and Storage Temperature Range	$T_J, T_{STG}$	-55 to 175	$^\circ\text{C}$

**Thermal Characteristics**

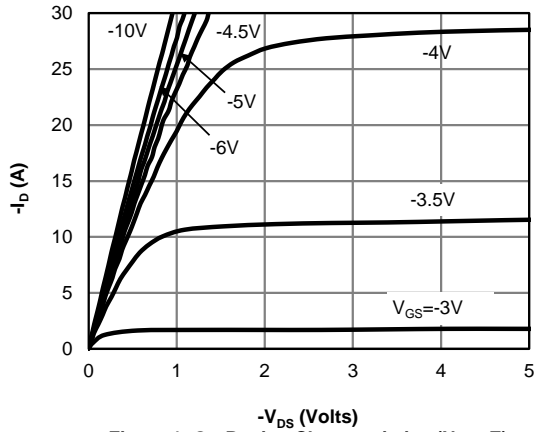
Parameter	Symbol	Typ	Max	Units
Maximum Junction-to-Ambient <sup>A</sup>	$R_{\theta JA}$	$t \leq 10\text{s}$	16.7	$^\circ\text{C/W}$
Maximum Junction-to-Ambient <sup>A,D</sup>		Steady-State	40	
Maximum Junction-to-Case	$R_{\theta JC}$	1.9	2.5	$^\circ\text{C/W}$

Electrical Characteristics ( $T_J=25^\circ\text{C}$  unless otherwise noted)

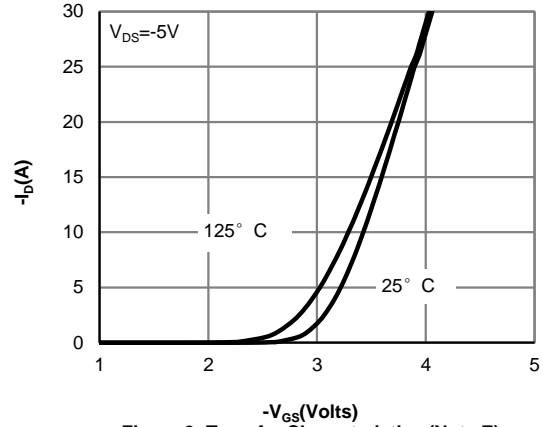
Symbol	Parameter	Conditions	Min	Typ	Max	Units
<b>STATIC PARAMETERS</b>						
$BV_{DSS}$	Drain-Source Breakdown Voltage	$I_D=-250\mu\text{A}$ , $V_{GS}=0\text{V}$	-60			V
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS}=-48\text{V}$ , $V_{GS}=0\text{V}$ $T_J=55^\circ\text{C}$			-1 -5	$\mu\text{A}$
$I_{GSS}$	Gate-Body leakage current	$V_{DS}=0\text{V}$ , $V_{GS}=\pm 20\text{V}$			$\pm 100$	nA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$ , $I_D=-250\mu\text{A}$	-1.2	-1.9	-2.4	V
$I_{D(ON)}$	On state drain current	$V_{GS}=-10\text{V}$ , $V_{DS}=-5\text{V}$	-80			A
$R_{DS(ON)}$	Static Drain-Source On-Resistance	$V_{GS}=-10\text{V}$ , $I_D=-20\text{A}$ $T_J=125^\circ\text{C}$		32 53	40	m $\Omega$
		$V_{GS}=-4.5\text{V}$ , $I_D=-20\text{A}$		43	55	m $\Omega$
$g_{FS}$	Forward Transconductance	$V_{DS}=-5\text{V}$ , $I_D=-20\text{A}$		32		S
$V_{SD}$	Diode Forward Voltage	$I_S=-1\text{A}$ , $V_{GS}=0\text{V}$		-0.73	-1	V
$I_S$	Maximum Body-Diode Continuous Current				-30	A
<b>DYNAMIC PARAMETERS</b>						
$C_{iss}$	Input Capacitance	$V_{GS}=0\text{V}$ , $V_{DS}=-30\text{V}$ , $f=1\text{MHz}$		2977	3600	pF
$C_{oss}$	Output Capacitance			241		pF
$C_{riss}$	Reverse Transfer Capacitance			153		pF
$R_g$	Gate resistance	$f=1\text{MHz}$		2	2.4	$\Omega$
<b>SWITCHING PARAMETERS</b>						
$Q_g(10\text{V})$	Total Gate Charge	$V_{GS}=-10\text{V}$ , $V_{DS}=-30\text{V}$ , $I_D=-20\text{A}$		44	54	nC
$Q_g(4.5\text{V})$	Total Gate Charge			22.2	28	nC
$Q_{gs}$	Gate Source Charge			9		nC
$Q_{gd}$	Gate Drain Charge			10		nC
$t_{D(on)}$	Turn-On Delay Time	$V_{GS}=-10\text{V}$ , $V_{DS}=-30\text{V}$ , $R_L=1.5\Omega$ , $R_{GEN}=3\Omega$		12		ns
$t_r$	Turn-On Rise Time			14.5		ns
$t_{D(off)}$	Turn-Off Delay Time			38		ns
$t_f$	Turn-Off Fall Time			15		ns
$t_{rr}$	Body Diode Reverse Recovery Time	$I_F=-20\text{A}$ , $dI/dt=100\text{A}/\mu\text{s}$		40	50	ns
$Q_{rr}$	Body Diode Reverse Recovery Charge	$I_F=-20\text{A}$ , $dI/dt=100\text{A}/\mu\text{s}$		59		nC

- A. The value of  $R_{\theta JA}$  is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ . The Power dissipation  $P_{DSM}$  is based on  $R_{\theta JA} \leq 10\text{s}$  and the maximum allowed junction temperature of  $150^\circ\text{C}$ . The value in any given application depends on the user's specific board design, and the maximum temperature of  $175^\circ\text{C}$  may be used if the PCB allows it.
- B. The power dissipation  $P_D$  is based on  $T_{J(MAX)}=175^\circ\text{C}$ , using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.
- C. Single pulse width limited by junction temperature  $T_{J(MAX)}=175^\circ\text{C}$ .
- D. The  $R_{\theta JA}$  is the sum of the thermal impedance from junction to case  $R_{\theta JC}$  and case to ambient.
- E. The static characteristics in Figures 1 to 6 are obtained using  $<300\mu\text{s}$  pulses, duty cycle 0.5% max.
- F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of  $T_{J(MAX)}=175^\circ\text{C}$ . The SOA curve provides a single pulse rating.
- G. The maximum current rating is package limited.
- H. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ .

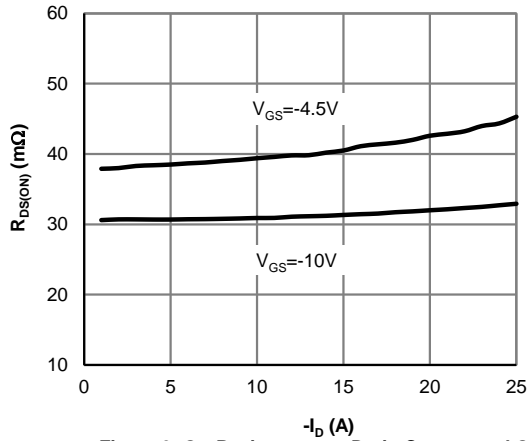
**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**



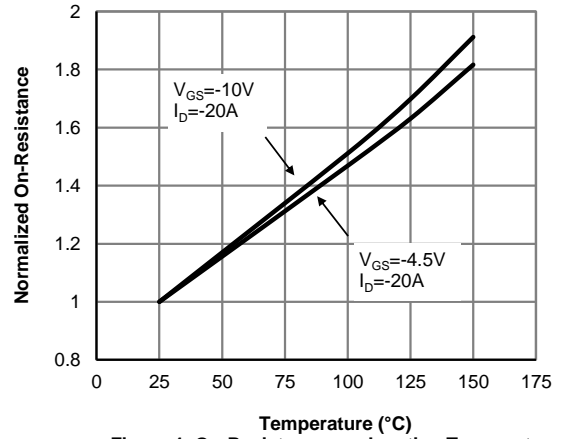
**Figure 1: On-Region Characteristics (Note E)**



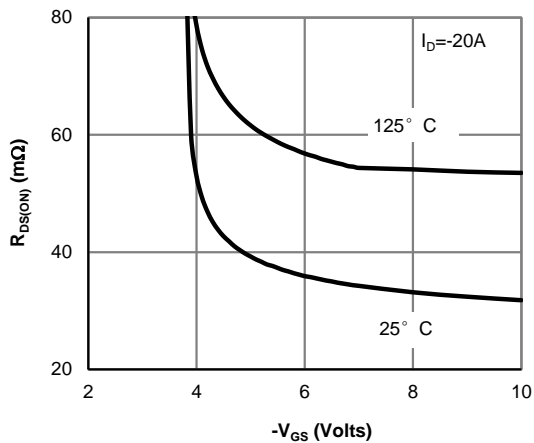
**Figure 2: Transfer Characteristics (Note E)**



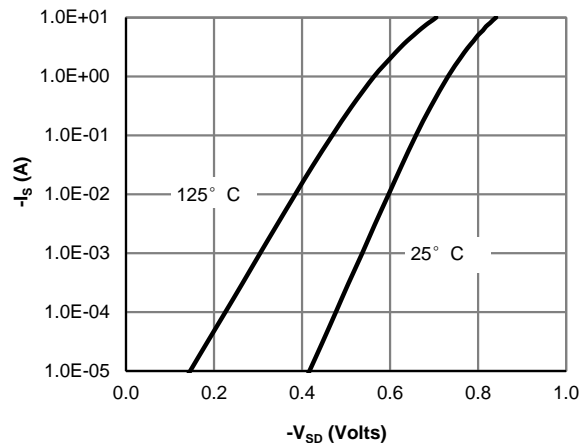
**Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)**



**Figure 4: On-Resistance vs. Junction Temperature (Note E)**

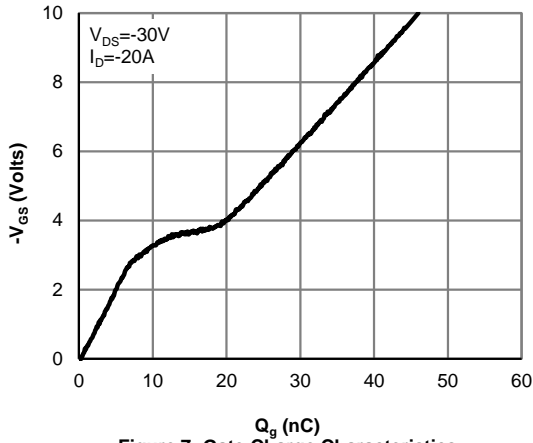


**Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)**

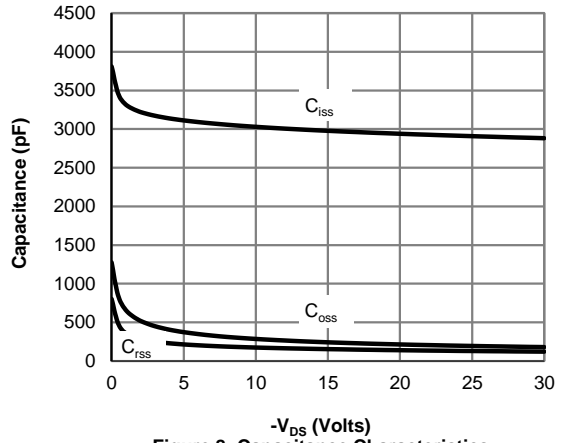


**Figure 6: Body-Diode Characteristics (Note E)**

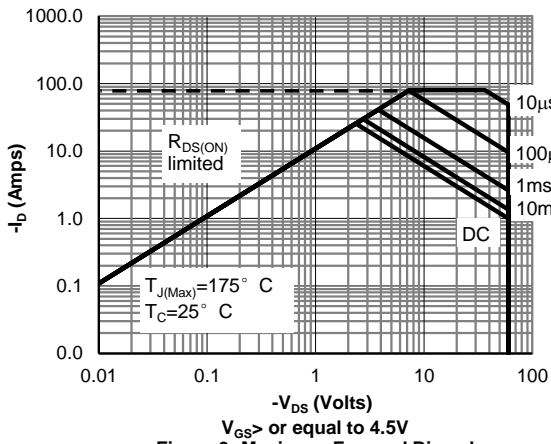
**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**



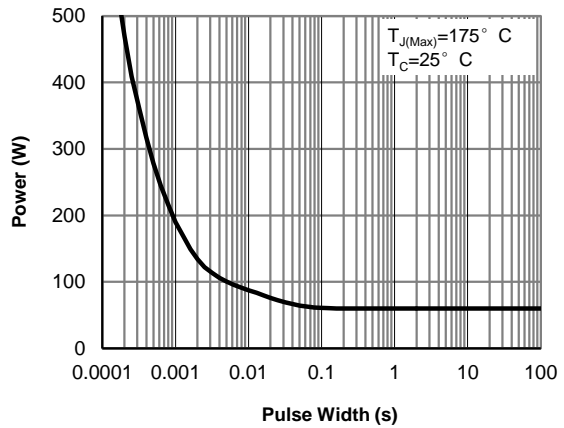
**Figure 7: Gate-Charge Characteristics**



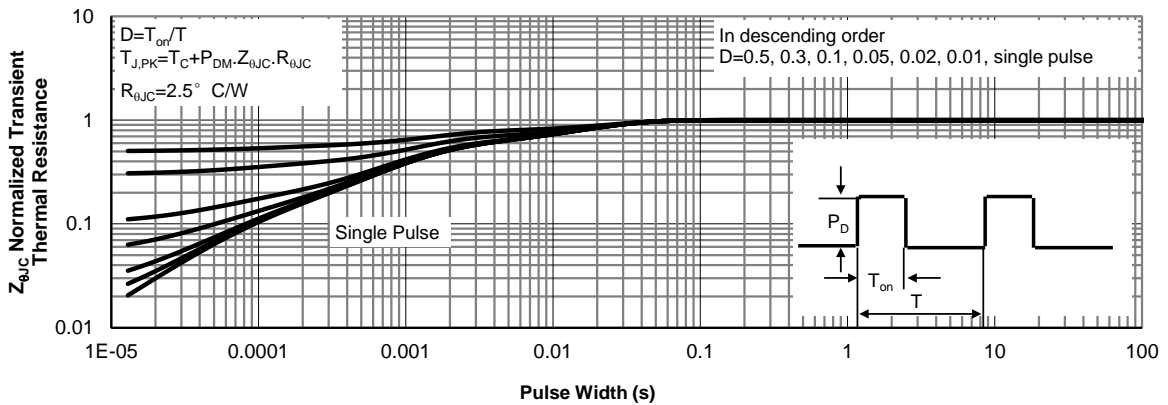
**Figure 8: Capacitance Characteristics**



**Figure 9: Maximum Forward Biased Safe Operating Area (Note F)**



**Figure 10: Single Pulse Power Rating Junction-to-Case (Note F)**



**Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)**

**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**

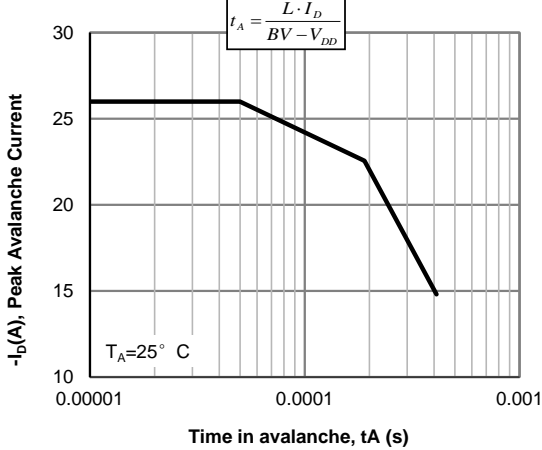


Figure 12: Single Pulse Avalanche capability

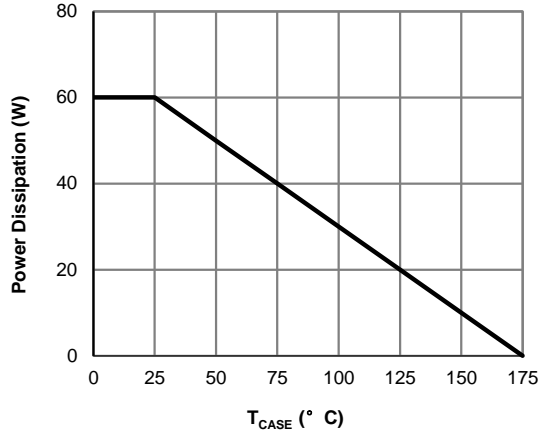


Figure 13: Power De-rating (Note F)

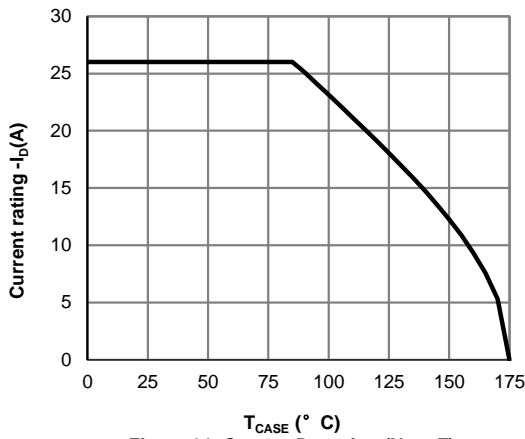


Figure 14: Current De-rating (Note F)

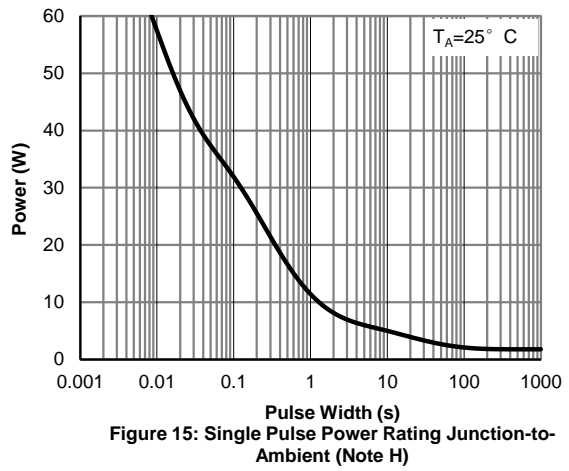


Figure 15: Single Pulse Power Rating Junction-to-Ambient (Note H)

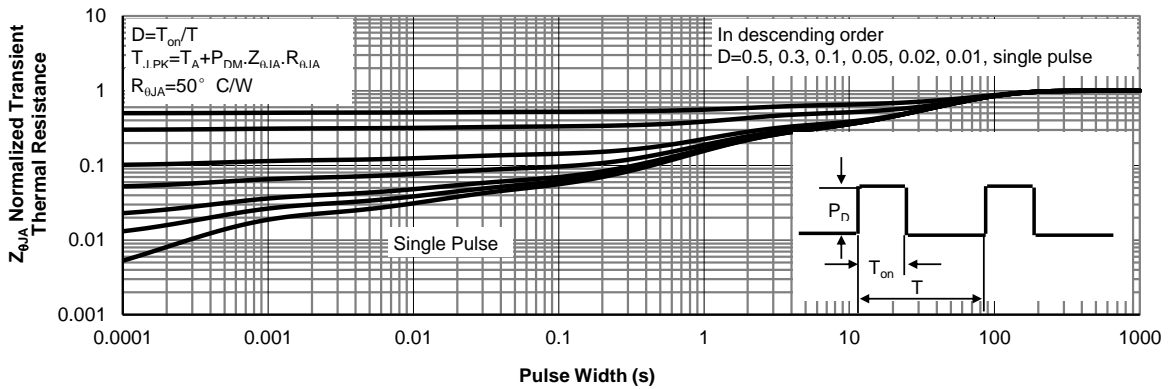
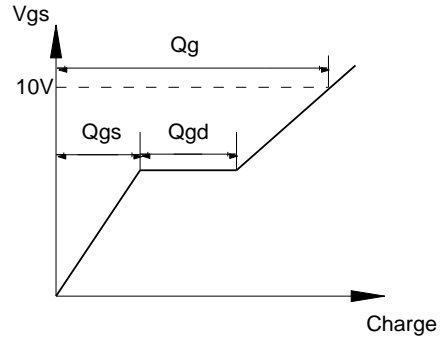
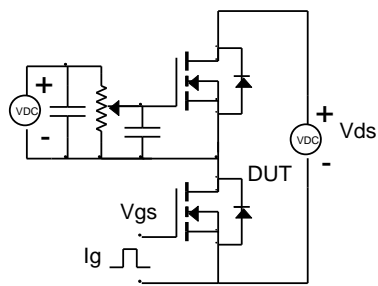
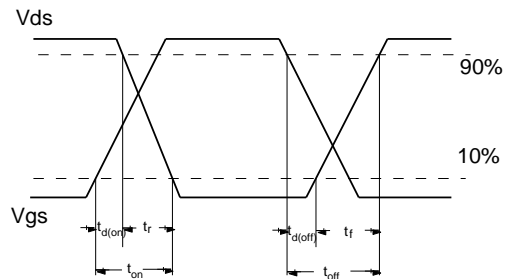
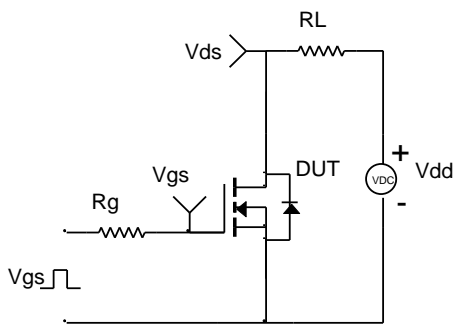


Figure 16: Normalized Maximum Transient Thermal Impedance (Note H)

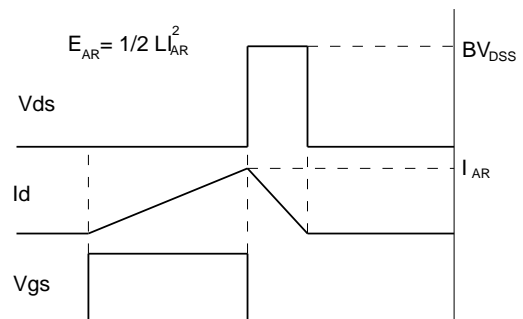
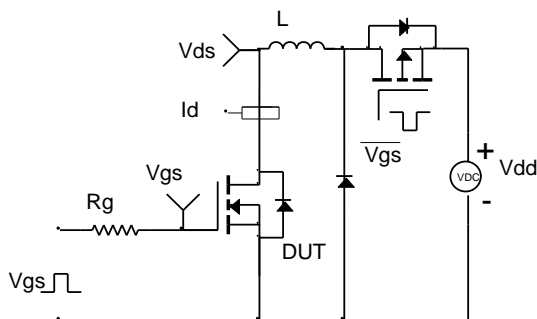
### Gate Charge Test Circuit & Waveform



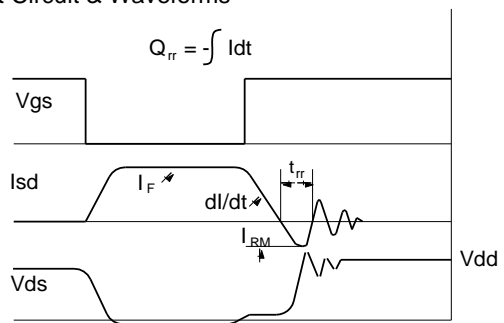
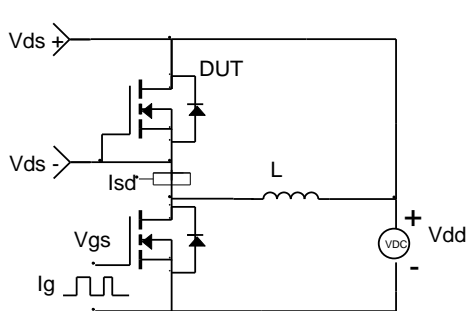
### Resistive Switching Test Circuit & Waveforms



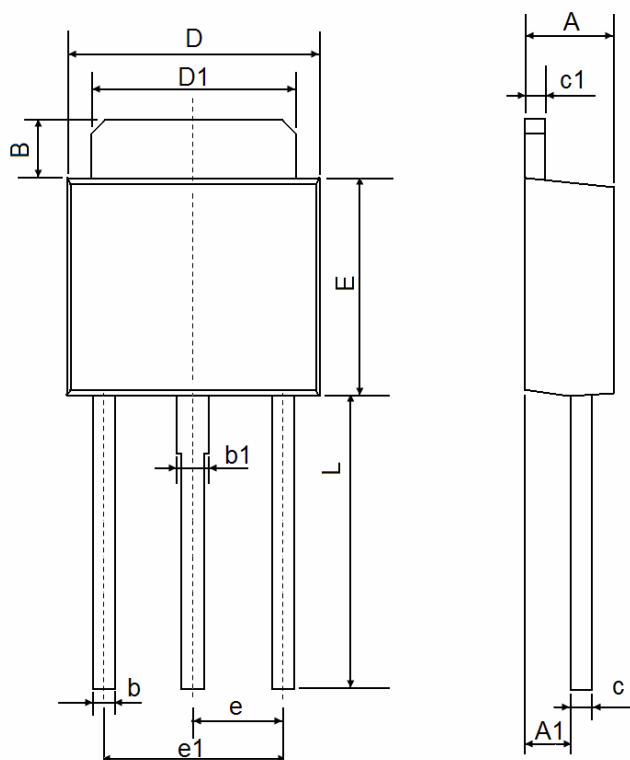
### Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



### Diode Recovery Test Circuit & Waveforms



## TO-251 Package Information



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	2.200	2.400	0.087	0.094
A1	1.050	1.350	0.042	0.054
B	1.350	1.650	0.053	0.065
b	0.500	0.700	0.020	0.028
b1	0.700	0.900	0.028	0.035
c	0.430	0.580	0.017	0.023
c1	0.430	0.580	0.017	0.023
D	6.350	6.650	0.250	0.262
D1	5.200	5.400	0.205	0.213
E	5.400	5.700	0.213	0.224
e	2.300 TYP.		0.091 TYP.	
e1	4.500	4.700	0.177	0.185
L	3.800	7.900	0.295	0.311

### Notes

1. All dimensions are in millimeters.
2. Tolerance  $\pm 0.10\text{mm}$  (4 mil) unless otherwise specified
3. Package body sizes exclude mold flash and gate burrs. Mold flash at the non-lead sides should be less than 5 mils.
4. Dimension L is measured in gauge plane.
5. Controlling dimension is millimeter, converted inch dimensions are not necessarily exact